

Application/Control No.	Applicant(s)/Patent under Reexamination		
09/710,487	HENCH ET AL.		
Examiner	Art Unit		
Thien D. Tran	2616		

SEARCHED				
Class	Subclass	Date	Examiner	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST (USPGPUB, USPAT, USOCR, EPO, DERWENT), Consulted with Reinhard Eisenzopf on 101	9/28/2006	тт
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